



# X-band dielectric assist accelerating structure

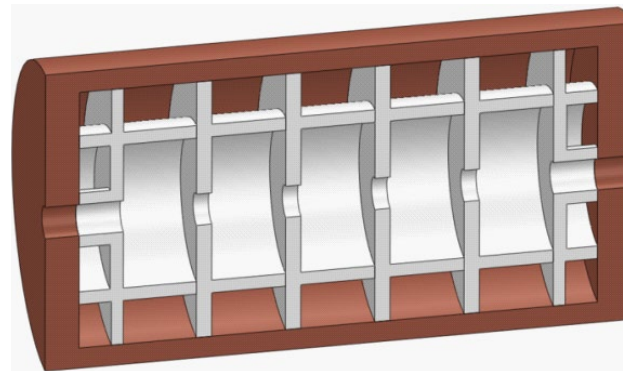
Daisuke Satoh<sup>1,2</sup>, Tetsuo Abe<sup>2</sup>, Mitsuo Akemoto<sup>2</sup>, Shuji Matsumoto<sup>2</sup>,  
Toshikazu Takatomi<sup>2</sup>, Yasuo Higashi<sup>2</sup>, Toshiyasu Higo<sup>2</sup>

1. National Institute of Advanced Industrial Science and Technology (AIST)
2. High energy accelerator research organization (KEK)

# 【Outline】

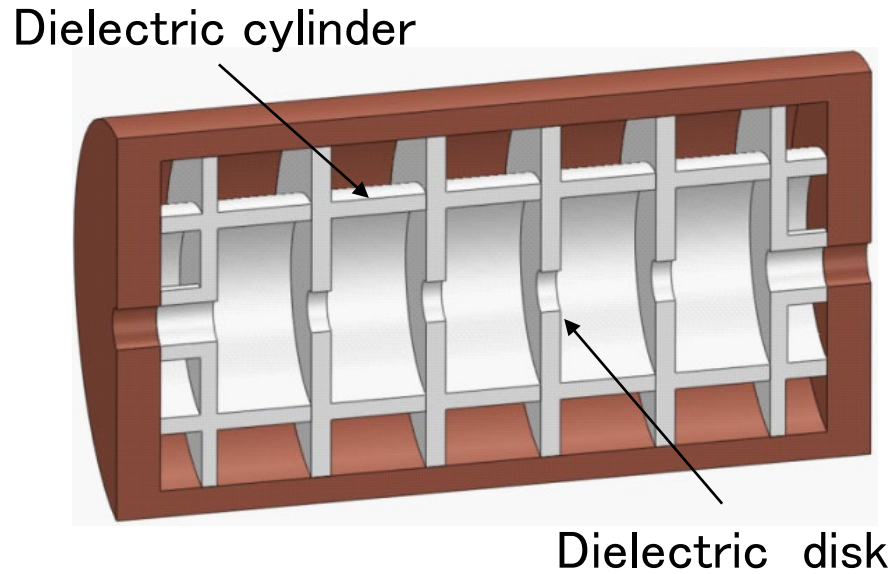
- Operation principle of DAA structure
- Current issues and initiatives
- Design, fabrication, and cold test of X-band DAA structure
- High power test (2024/6/25 ~)
- Summary & Research plan

Dielectric assist accelerating structure, DAA



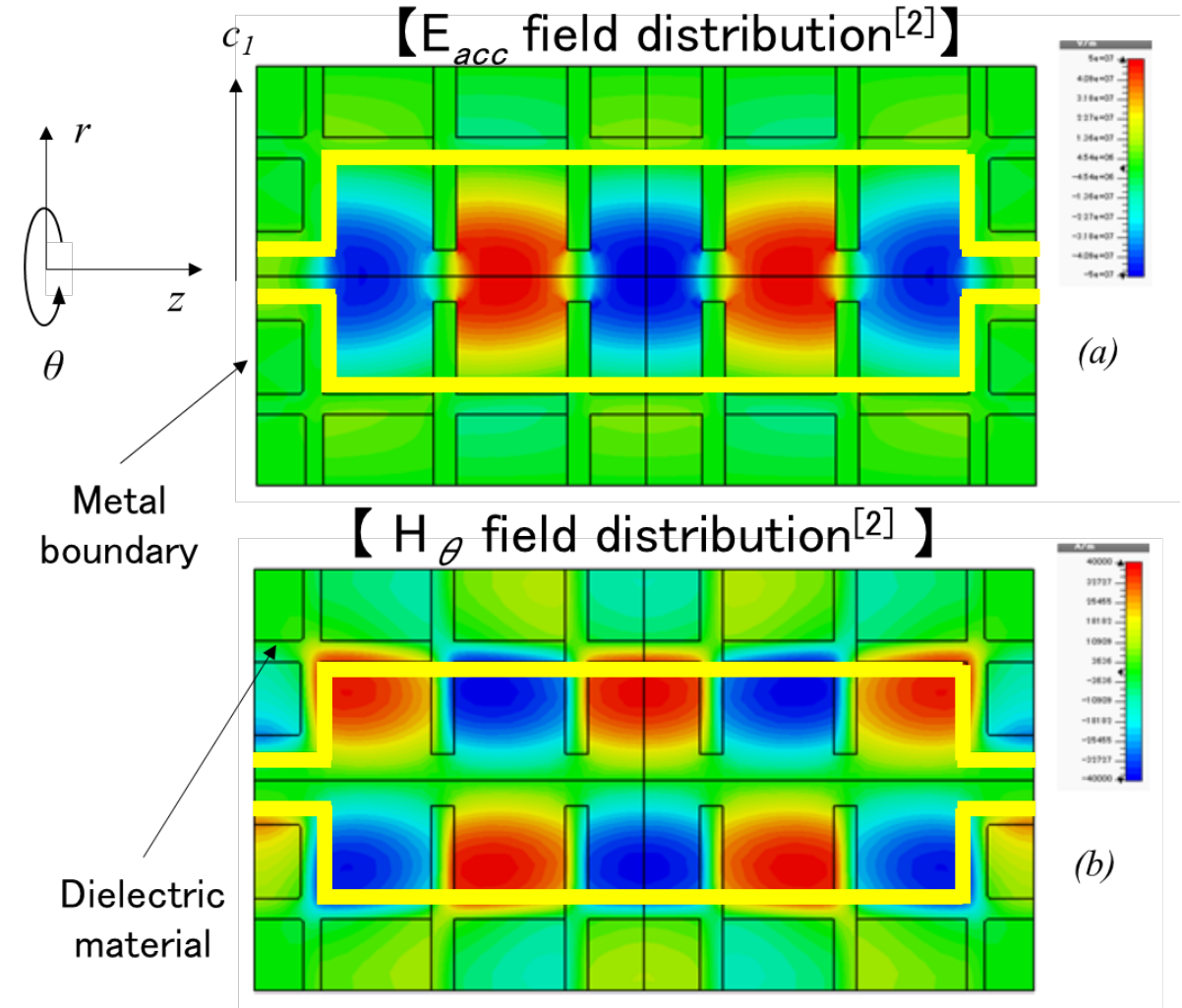
# 【 Dielectric assist accelerating (DAA) structure 】

## 【 Conceptual diagram of DAA structure 】



- DAA consists of **dielectric cylinders and disks with irises** which are periodically arranged in a metallic enclosure.
- Higher order  **$TM_{02n}$  mode** is used for beam acceleration.

→ **Wall loss on conducting surface is drastically reduced in DAA structure**



[1] D. Satoh, et al., PRAB 19, 011302 (2016)

[2] D. Satoh, et. al., PRAB 20, 091302 (2017)

Patent : PCT/JP2016/087683

# 【 Current issues and initiatives 】

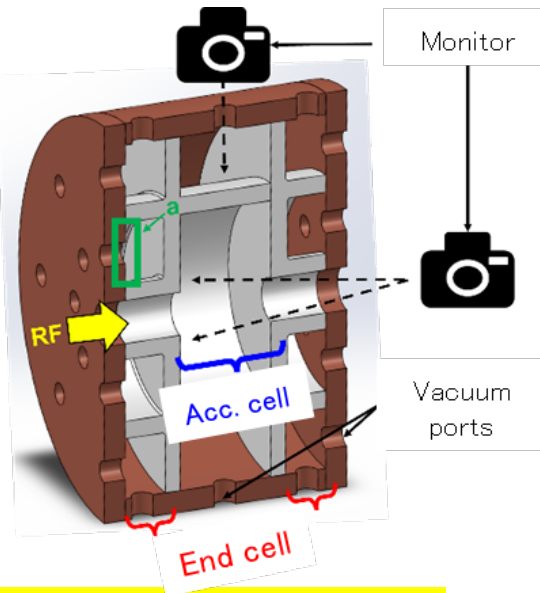
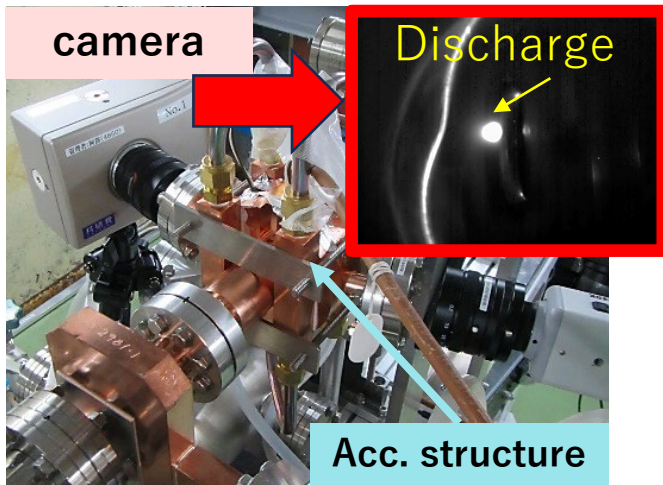
◎ High shunt impedance  $Z_{sh} \sim 600 \text{ M}\Omega/\text{m}$  @ 5.712 GHz was realized.

×  $E_{acc,max} \sim 11 \text{ MV/m}$  @ DLC-coating MgO cells is limited by multipactor and discharge.

## Toward higher gradient DAA structure

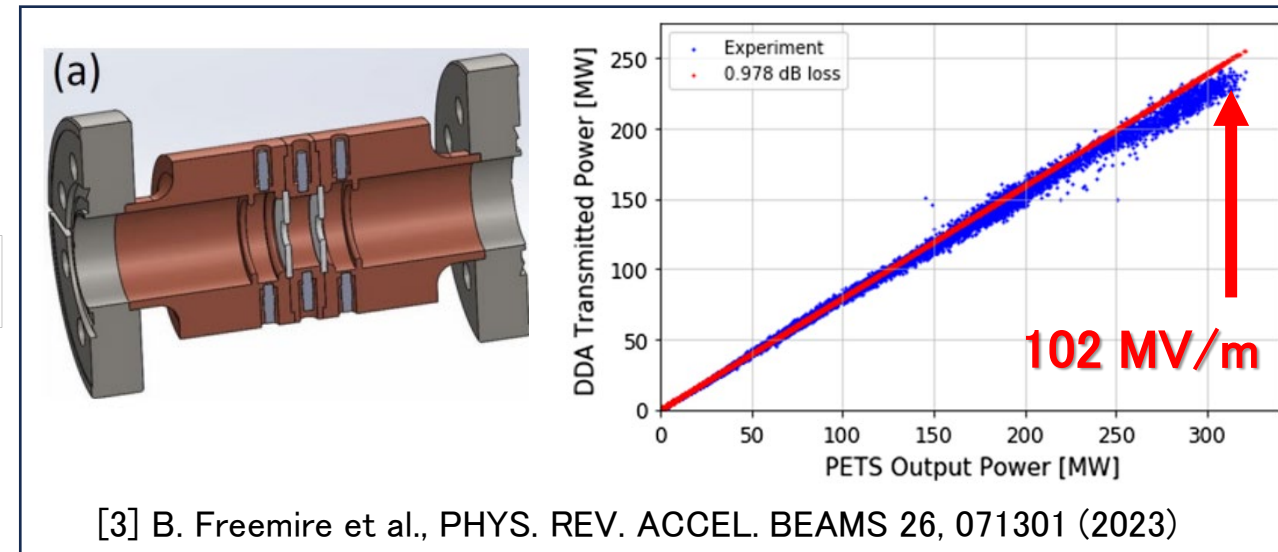
### 【 (i) Understanding discharge phenomena 】

【 previous study @KEK 】



### 【(ii) Short pulse excitation 】

High gradient was realized by short pulse dielectric disk accelerating structure.



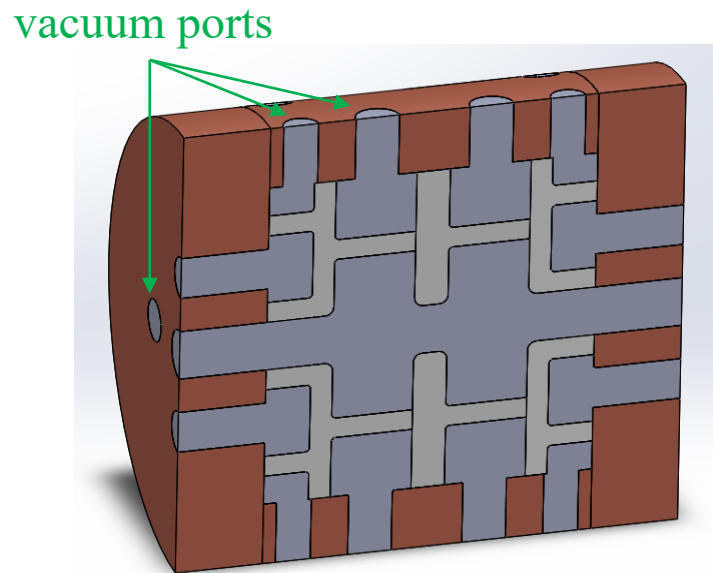
- Observation of discharge phenomena in DAA structures using (high-speed and Hyperspectral) cameras.
- Update of the internal structure based on the estimation of discharge locations and causes to achieve higher gradient.

Verify whether higher  $E_{acc}$  excitation is possible by inputting RF pulses shorter than the filling time.

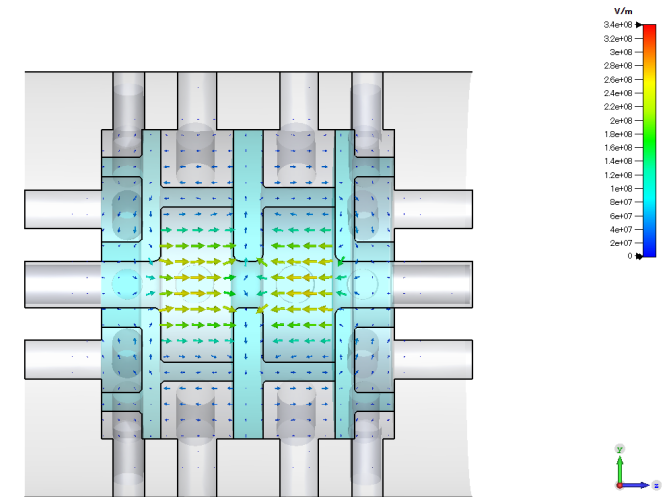
# 【RF Design of X-band DAA structure】

- Optimize the structure for high  $E_{acc}$  by deepening **the physical understanding of vacuum discharge** in DAA structures.
- We considered a DAA#X1 in which all closed regions within the DAA structure can be optically observed from the outside.

## 【Basic structure of DAA#X1】



## 【Simulation results】



**Dielectric material**

**SC - Sapphire**

$$\epsilon_{\perp} / \epsilon_{\parallel}$$

**9.395 / 11.586**

$$\tan\delta_{\perp} / \tan\delta_{\parallel}$$

**$1.6 \times 10^{-5} / 3.0 \times 10^{-5}$**

$$f_0$$

**11.424 GHz**

$$Q_0$$

**59,000**

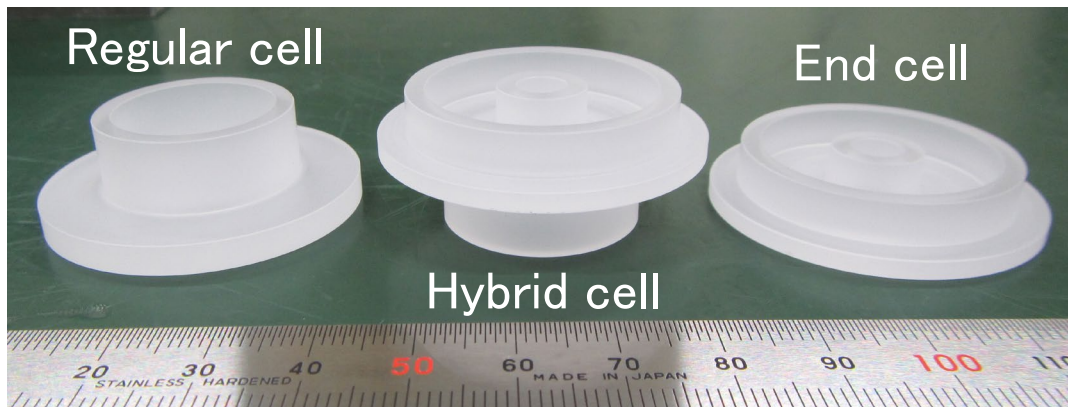
$$Z_{sh}$$

**400 M $\Omega$ /m**

- DAA#X1 is a 2-cell DAA structure.
- The DAA#x1 was designed to be introduced into the chamber.
- Many holes works as vacuum ports and observation ports

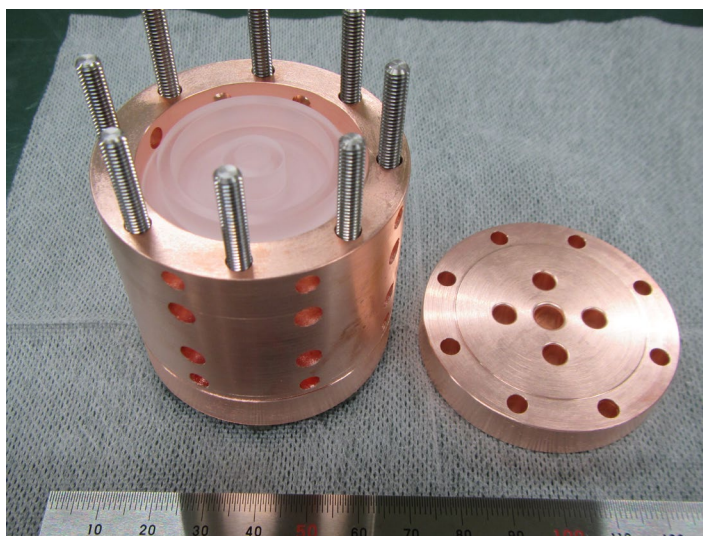
# 【 Fabrication and cold test of DAA#X1 】

## 【 Dielectric cells 】

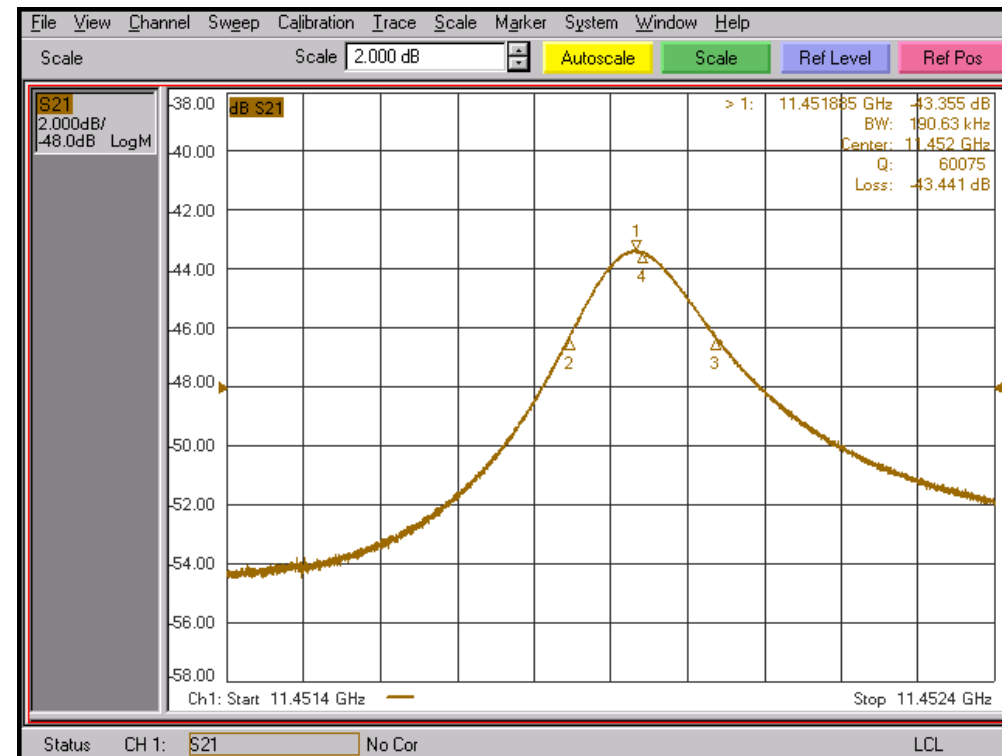


The tolerance of the dielectric cell was set to finish at a higher frequency than 11.424 GHz for frequency tuning.

## 【 Assembled DAA#X1 】



## 【 Results of low power test @ DAA#X1 】

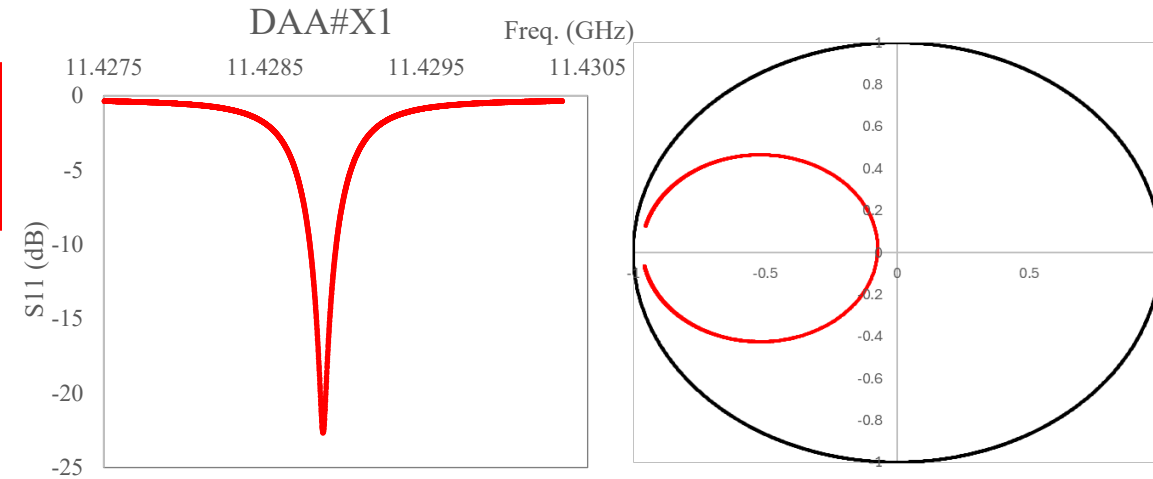
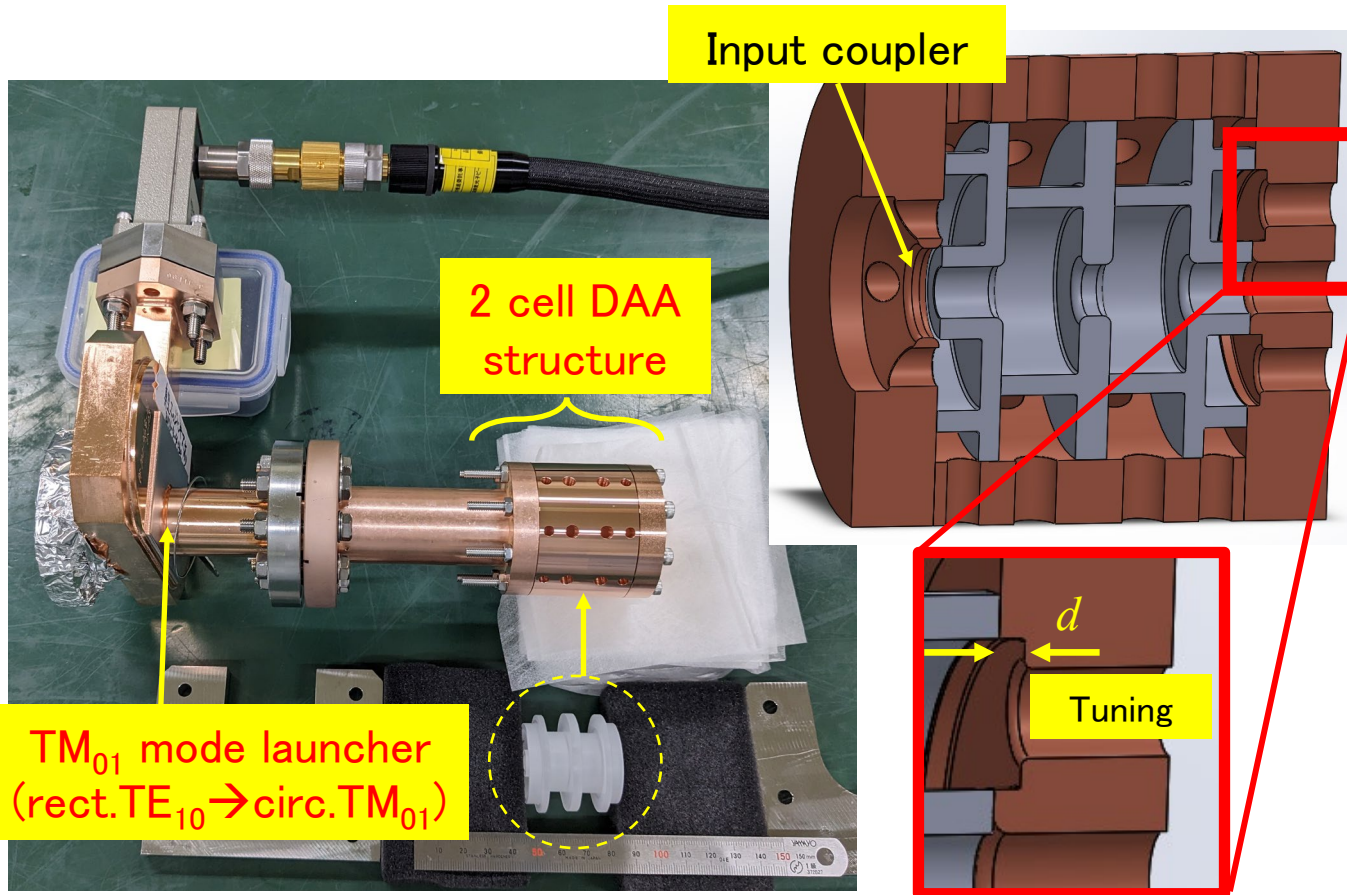


Parameters	Simulation Results	Measured Results
$f_0$	11.4526 GHz	11.4519 GHz
$Q_0$	59,000	60,000

# 【 Fabrication and cold test of DAA#X1 】

## 【 Coupler feed Assembly 】

## 【 Results of low power test @ DAA#X1 】



Parameters	Measured Results
$f_0$	11.4289 GHz
$Q_0$	<b>43,046</b>
$Q_{ext}$	50,971

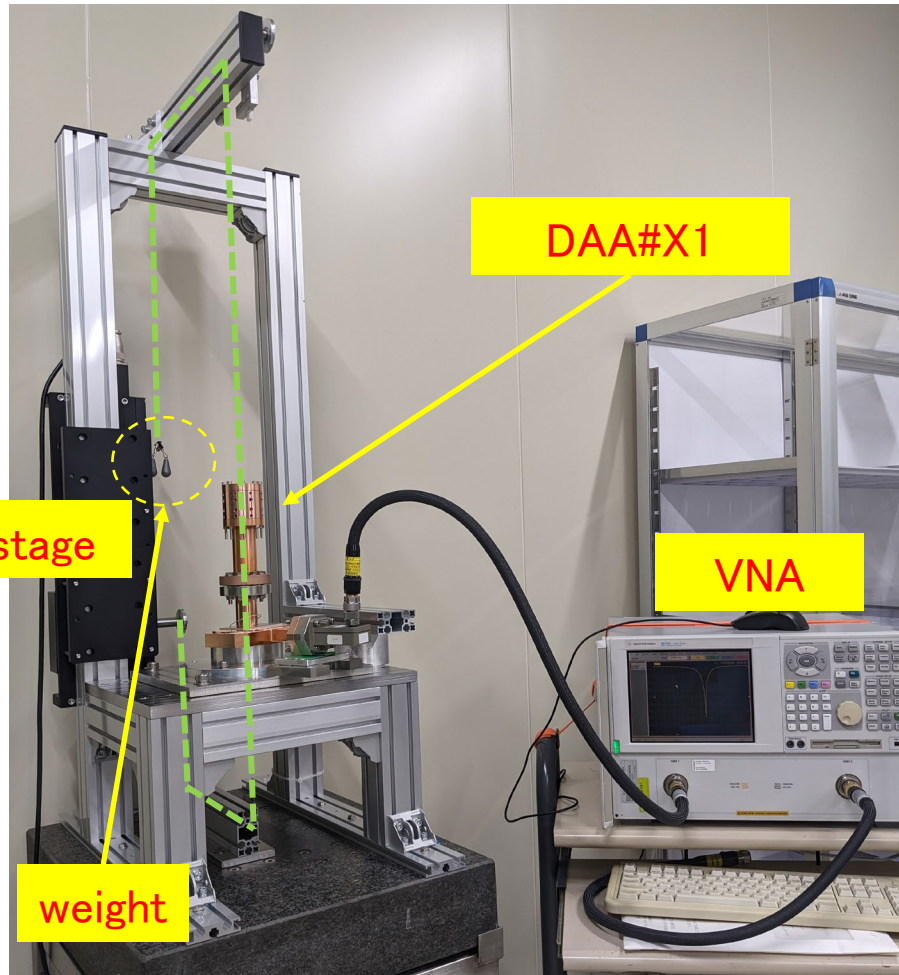
- DAA#X1 couples with the  $TM_{01}$  mode of the circular waveguide on the axis.
- The  $f_0$  was tuned by removing a portion ( $d$ ) of the copper end plate.

The distribution of the EM field changed due to the alteration of the end plate shape, leading to an increase in conductor loss and a decrease in  $Q_0$ .

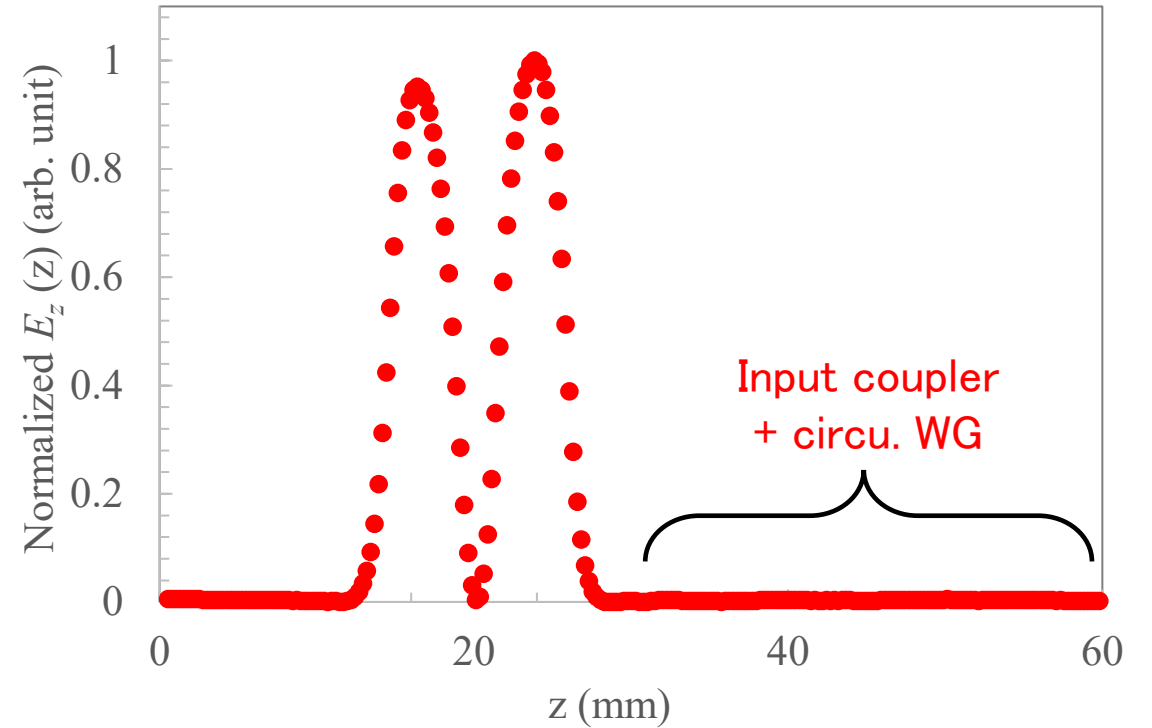
**Under investigation**

# 【 Bead pulling measurement of DAA#X1 】

【Bead pulling measurement】



【 $E_{acc}$  field along beam axis】



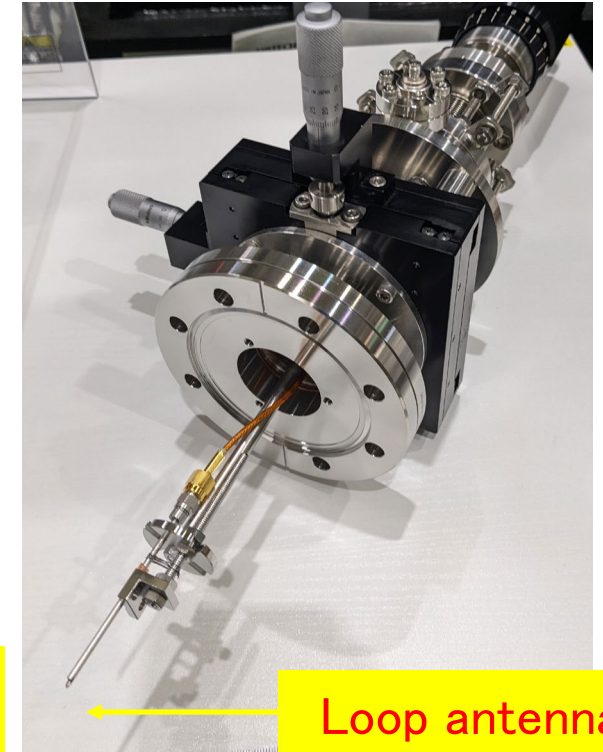
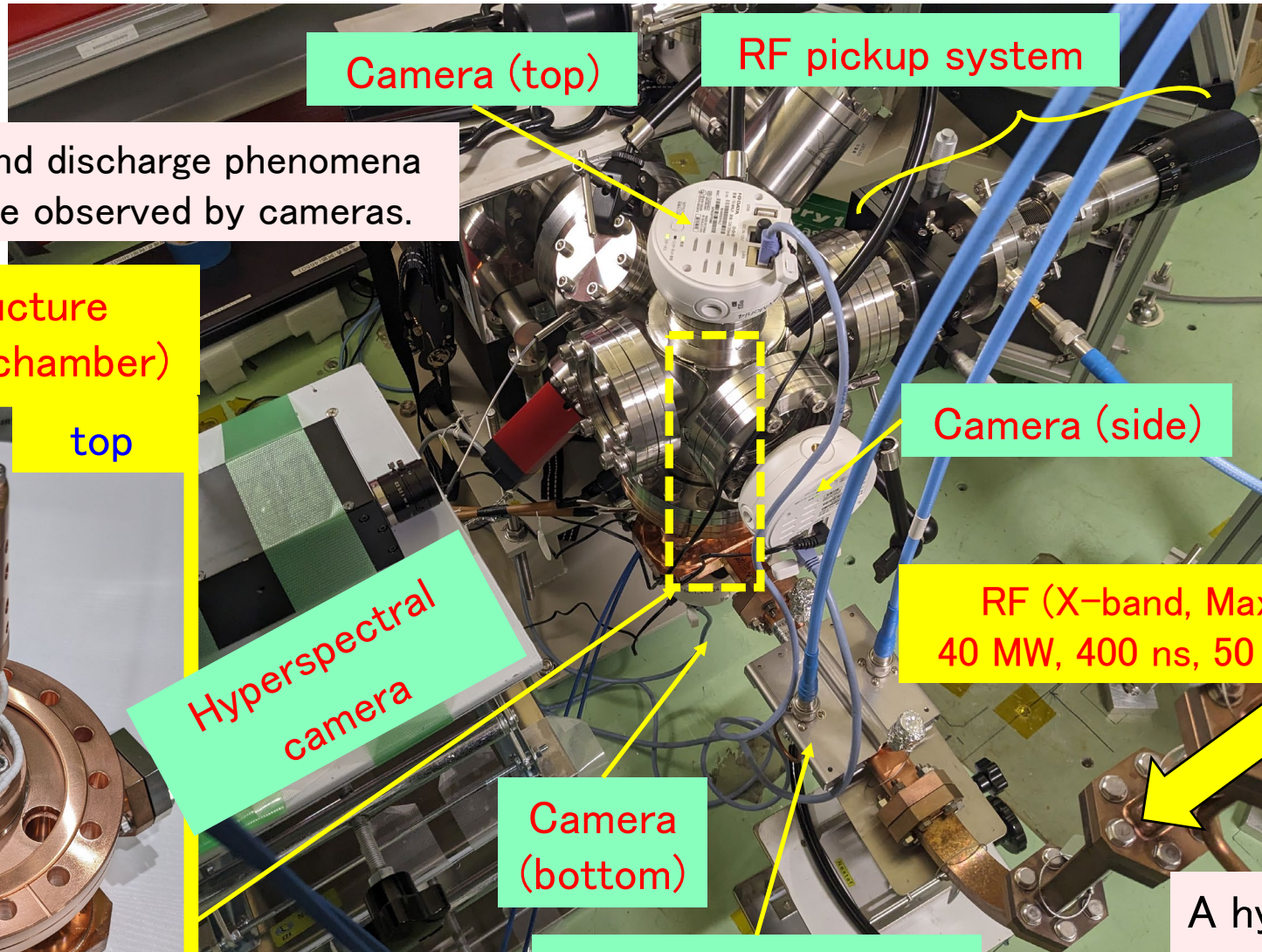
We confirmed that this particular resonance is in acceleration mode by employing bead-pulling measurement.



# 【 Setup for the high-power test in Nextef2/Shield-B 】

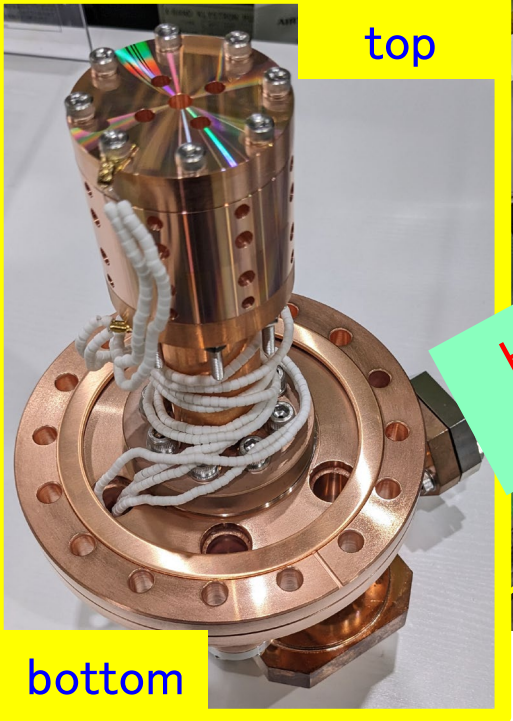
## 【 Setup in Nextef2/Shield-B 】

## 【 RF pickup system 】



Multipactor and discharge phenomena in DAA#X1 are observed by cameras.

DAA structure (in vacuum chamber)



top

bottom

Hyperspectral camera

RF (X-band, Max. 40 MW, 400 ns, 50 Hz)

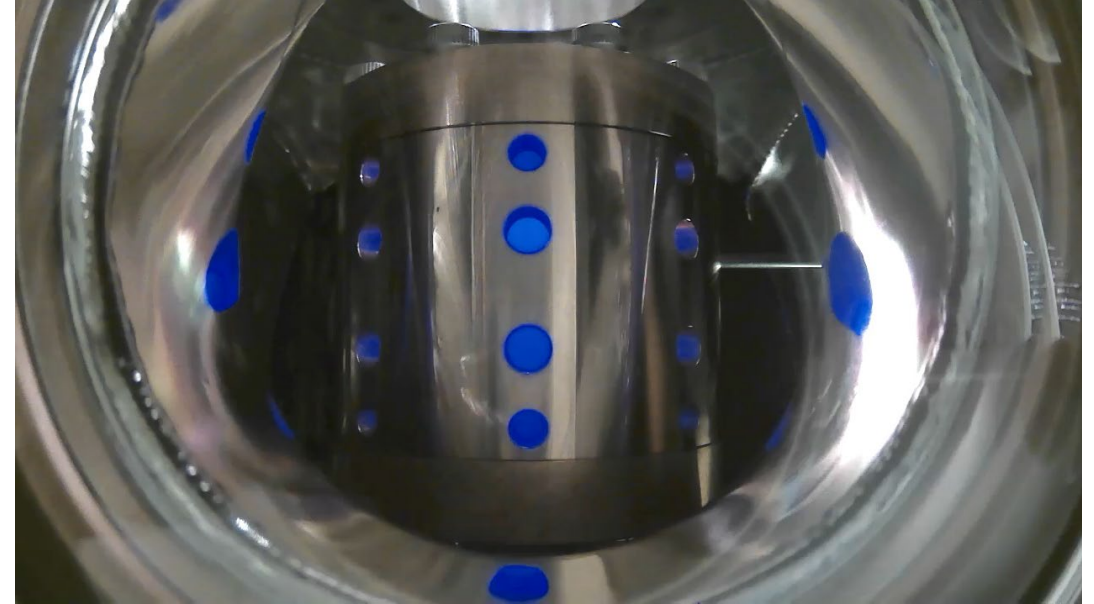
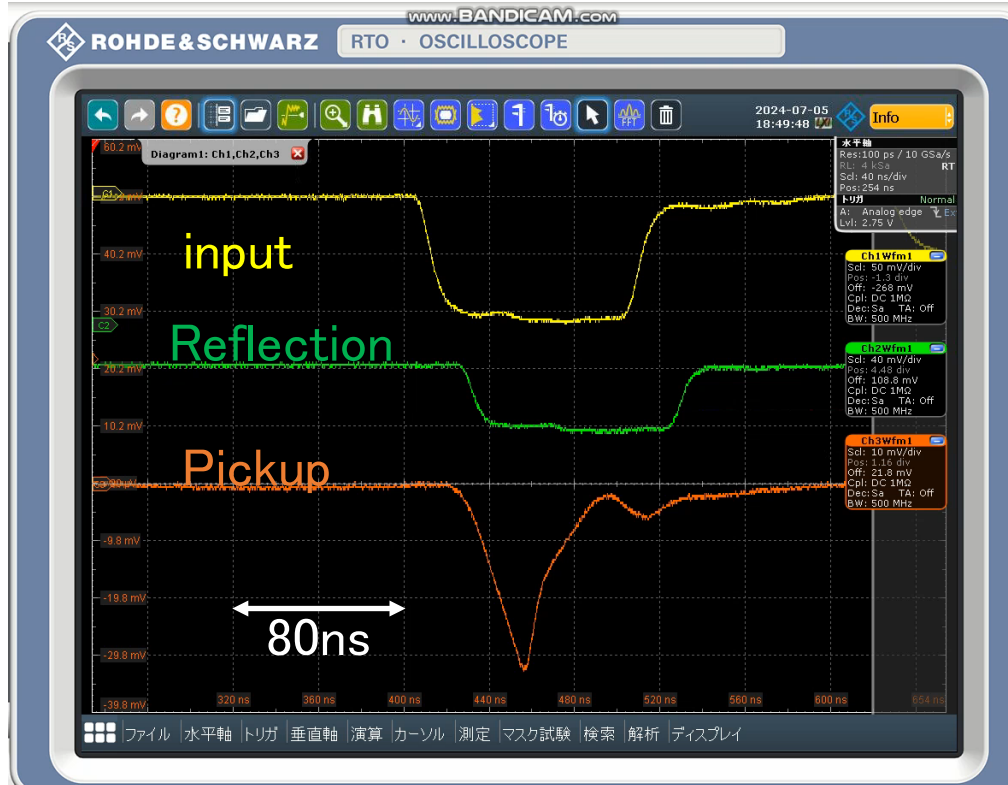
$E_{acc}$  is measured using a loop antenna from the side holes.

A hyperspectral camera are used to measure emission spectra.

# 【High-power (HP) test in Nextef2@KEK : 6/25 ~】

【Result : Pin = 90 kW, 100 ns, 5 Hz】

【Side view of DAA#X1】

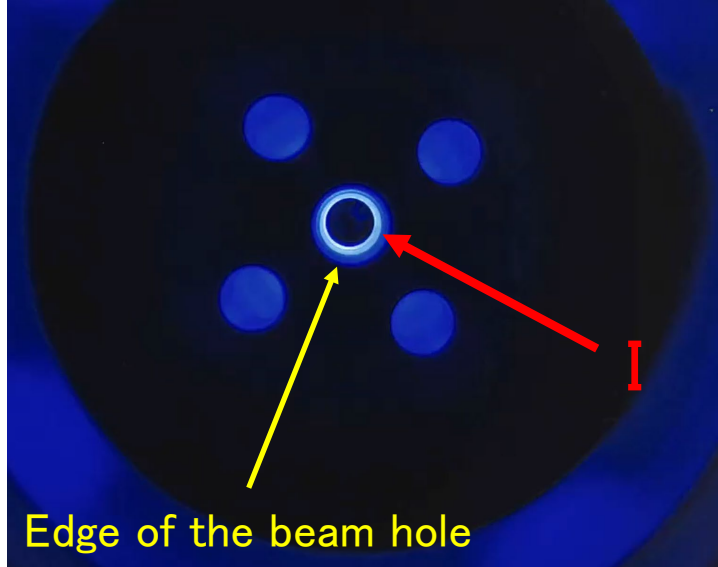


The color CMOS cameras detected blue luminescence.

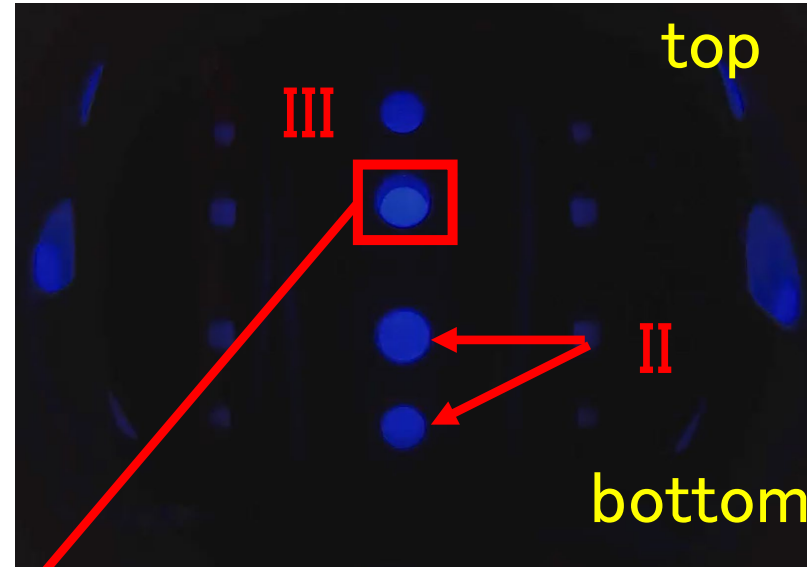
- The  $E_{acc}$  in DAA#X1 was unstable even with input power of a few kW.
- The time constant for  $E_{acc}$  buildup and decay are much shorter than the filling time of DAA#X1.  
→ multipactor or discharge may be occurring in the DAA#X1.
- The  $E_{acc}$  is still limited at about a few MV/m (2024/07/07).  
\* This trend is similar to the results for the prototype of DAA@C-band without DLC coating.

# 【Luminescence in DAA#X1 : 0.6 MW, 200 ns, 50 Hz】

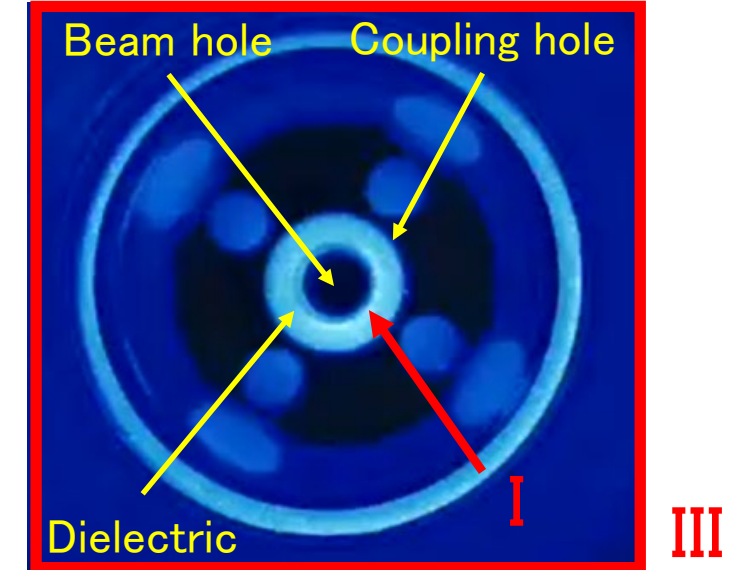
【top】



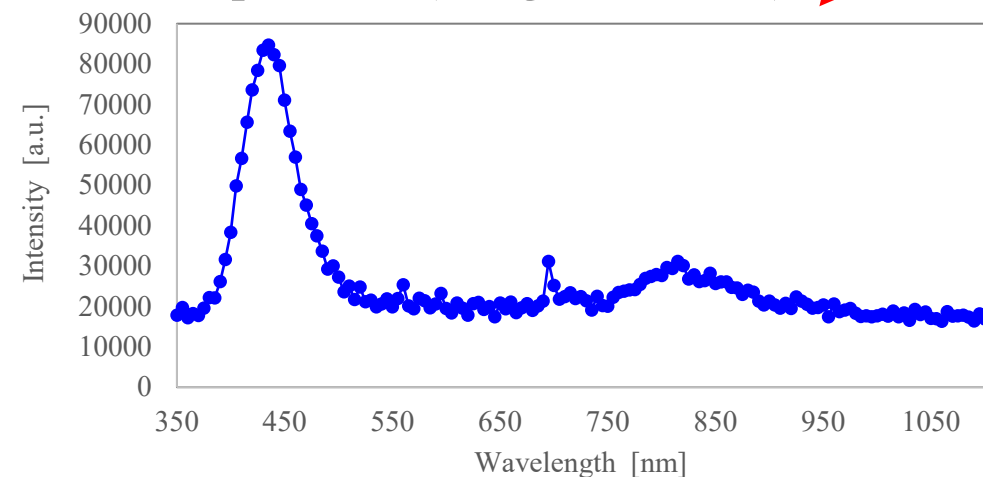
【side】



【bottom : coupler】



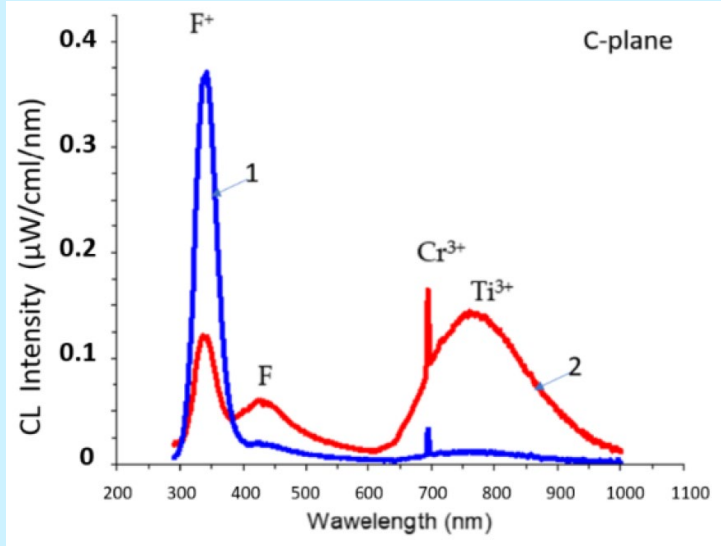
Spectrum (integrated in III)



- I. Significant luminescence was observed slightly inside the beam holes as the input power increased.
- II. The luminescence intensity observed from the side hole is much lower than that from the center area.
- III. A hyperspectral camera measured the luminescence spectrum from the vacuum holes (side and bottom), confirming a main peak at a wavelength of 435 nm.

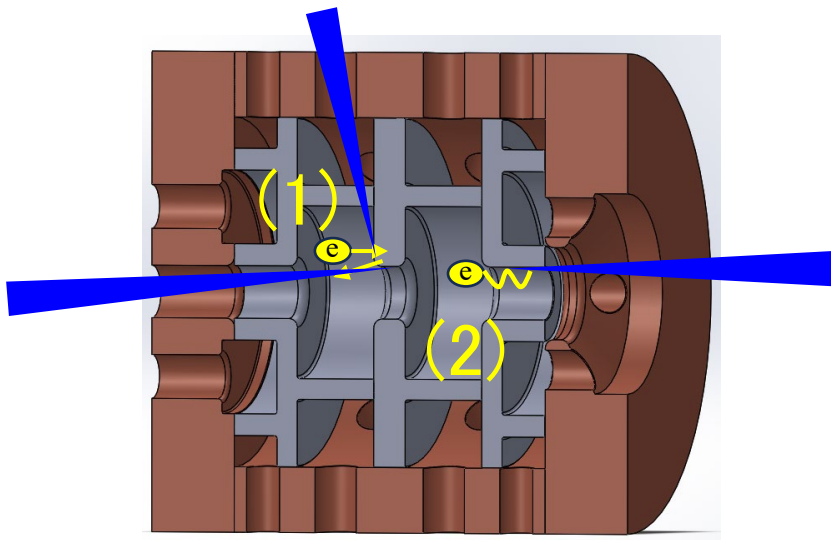
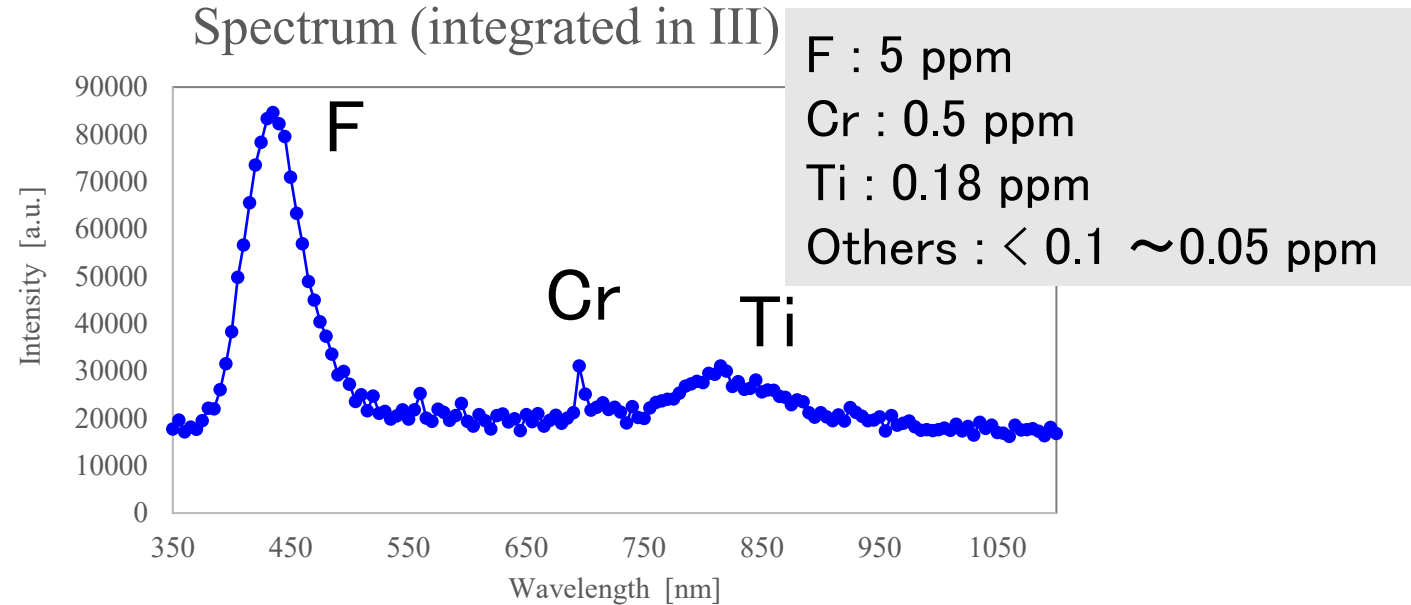
# 【Discussion : Luminescence in DAA#X1】

Cathodoluminescence spectrum of sapphire



[4] A. Muslimov and V. Kanevsky, Materials 2022, 15, 1332

Impurities of DAA#X1 sapphire



- The representative peak wavelengths of the luminescence from the DAA#x1 was match to that of **the cathodoluminescence spectrum in sapphire**.
- It is most likely that the luminescence is caused by impurities in the sapphire due to **electron impact by multipactors**.
- Multipactors may be occurring (1) between dielectric disks near the beam axis and (2) inner cylinder surface of end cell, etc... considering the luminescence intensity.

## 【 Summary 】

- To achieve a higher gradient in the DAA structure, high-power tests were initiated on June 25, 2024, to deepen our understanding of the physical phenomena within the DAA structure.
- During the high-power test, blue luminescence was detected by the color CMOS cameras. → **It is highly likely that this luminescence is caused by impurities in the sapphire due to electron impacts from multipactors.**
- Multipactors may be occurring between the dielectric disks near the beam axis and the inner cylinder surface of the end cell.

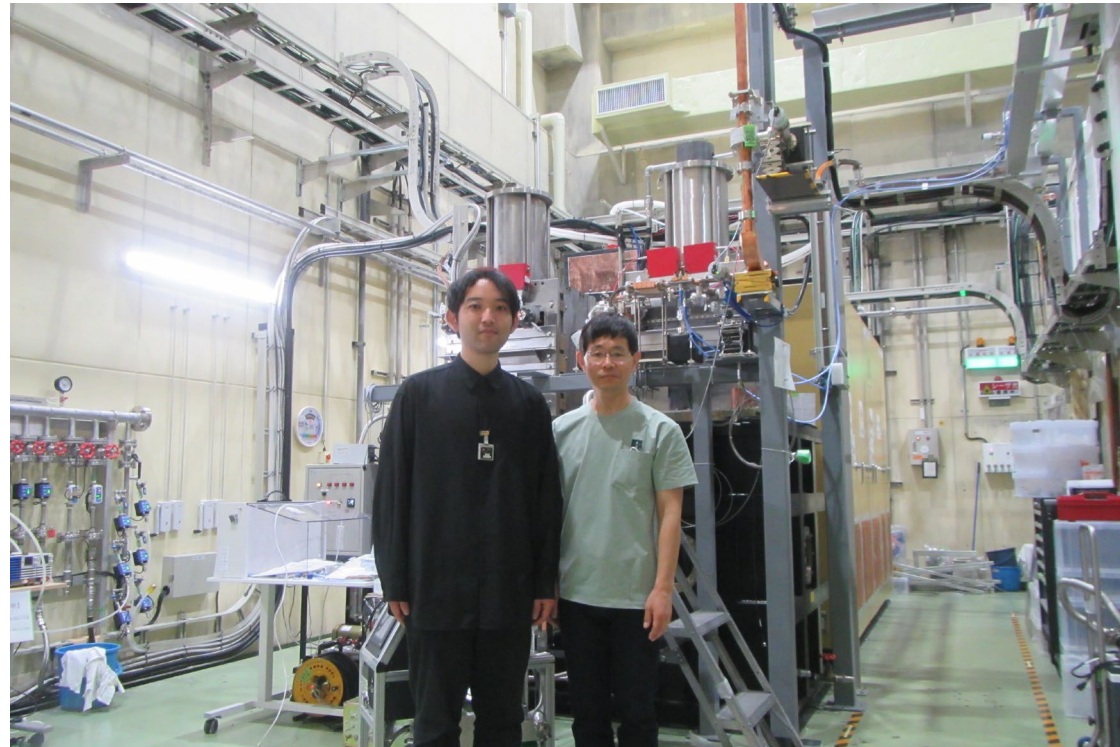
## 【 Research plan】

- High-power tests will continue to verify the conditioning effects of DAA structures and to measure temporal changes in discharge and multipactor phenomena.
- The locations of multipactors will be estimated in detail **by observing it from various angles.**
- Updates to the internal structure will be made based on these identified locations and causes of multipactor, with the aim of achieving a higher gradient.

## 【Acknowledgment】

This work has been supported by 【MEXT Development of key element technologies to improve the performance of future accelerators Program】 Japan Grant Number JPMXP1423812204.

**Thank you for your attention.**

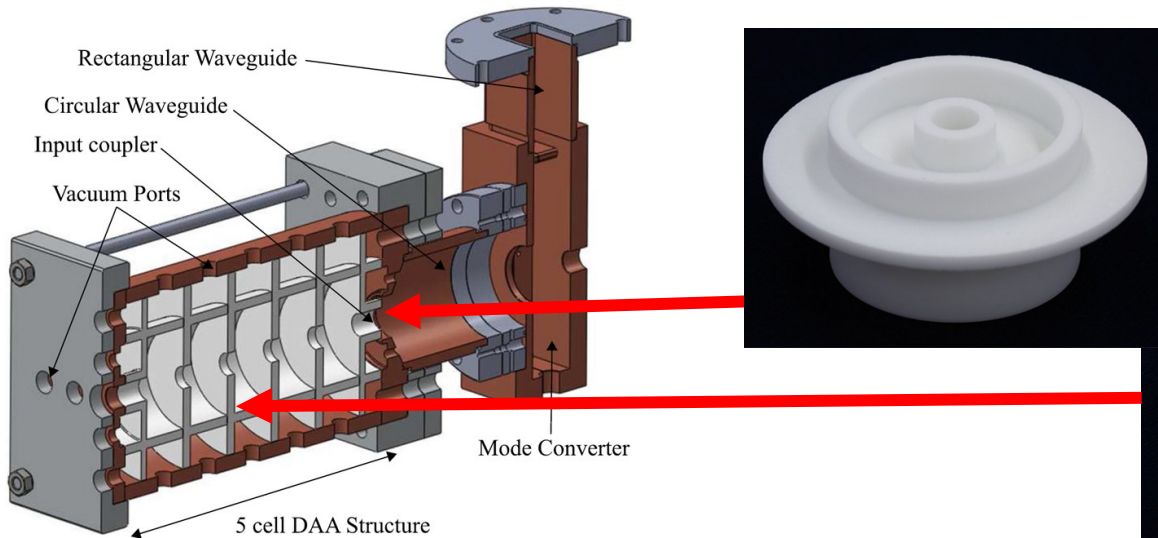


Additional slides

# 【 Accelerator performance of DAA structure<sup>[2]</sup>】

## 【Prototype : 5 cell C-band DAA structure】

## 【DAA structure assembly】



Dielectric cells



## 【Cavity parameters】

Parameter	Five-cell DAA structure
Dielectric material	Magnesia
$\epsilon_r$	9.64
$\tan \delta$	$6.0 \times 10^{-6}$
Accelerator type	Standing wave type
Accelerating mode	$TM_{02-\pi}$ mode
Operation frequency	5.712 GHz
Number of accelerating cells	5
Total cavity length	157.5 mm
$Q_0$	126,400
$Z_{sh}$	630 M $\Omega$ /m
$E_{max}/E_0$	2.92
$H_{max}/E_0$	2.74 mA/V

- $Q_{0, proto} > 10^5 @RT, C\text{-band}^{[2]}$
- $Z_{sh, proto} > 600 M\Omega/m @RT, C\text{-band}^{[2]}$



- $Z_{sh, proto}$  is **four times** higher than that of a NC accelerating structures !
- DAA structures have the potential to significantly increase the **electrical efficiency** of NC linacs, including LCs.

[2] D. Satoh, et. al., PRAB 20, 091302 (2017)



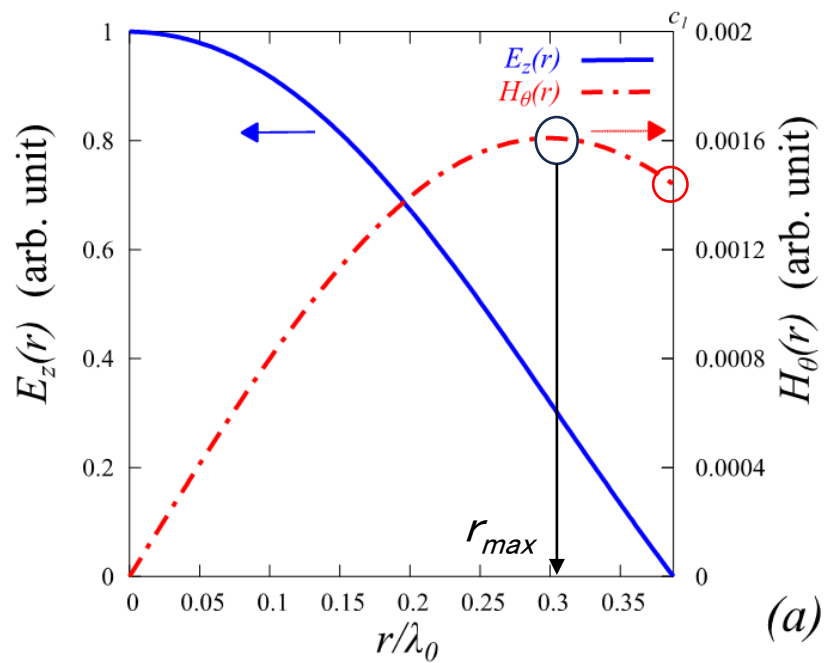
# 【 Mechanism of high- $Q_0$ 】

Wall loss on a conducting cylinder:  $P_{wall}$

$$P_{wall} \propto c_1 \times |H_\theta(c_1)|^2$$

\*  $c_1$ : inner radius of conductive cylinder

【Pillbox cavity】



(a)

【Pillbox cavity】

$$c_1 = 0.39 \lambda_0$$

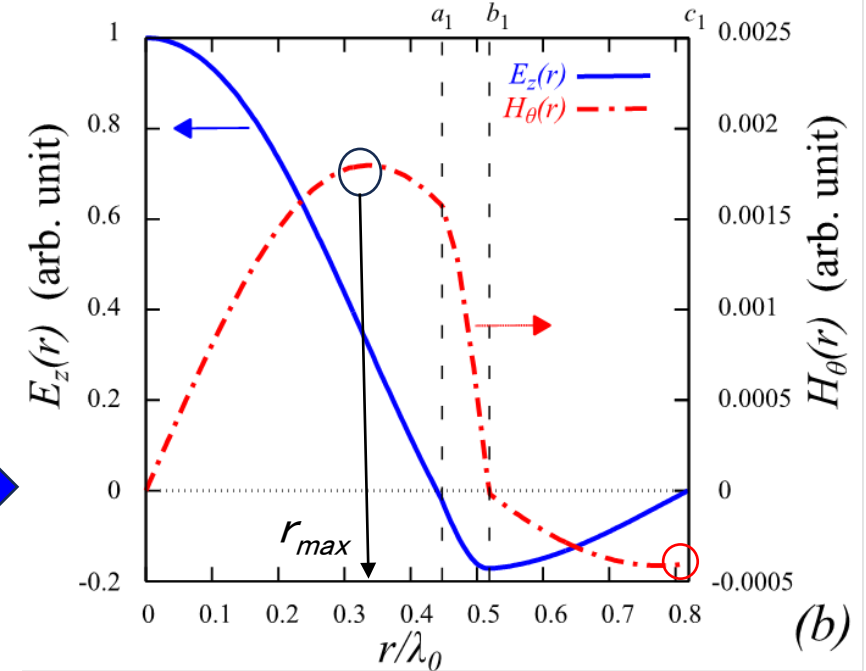
$$\frac{|H_\theta(c_1)|}{|H_\theta(r_{max})|} = 0.89$$

【DAA】

$$c_1 = 0.82 \lambda_0$$

$$\frac{|H_\theta(c_1)|}{|H_\theta(r_{max})|} = 0.23$$

【DAA structure】



(b)

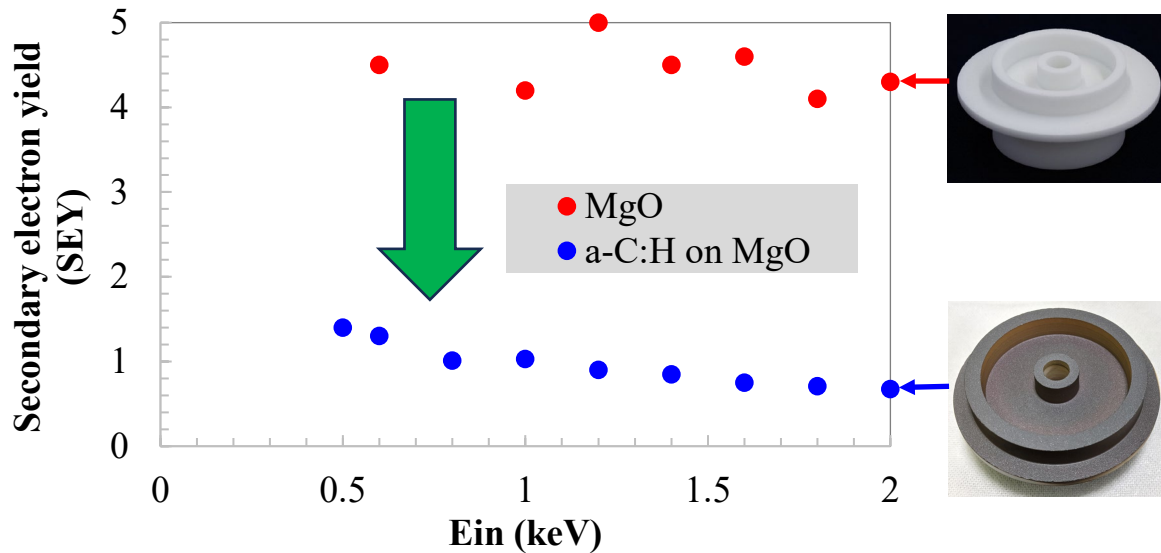
$|H_\theta(c_1)|$  in DAA structure is almost 1/4 that of pillbox cavity  
 → The wall loss on conducting cylinder is drastically reduced !

# 【Diamond like carbon coating on DAA】

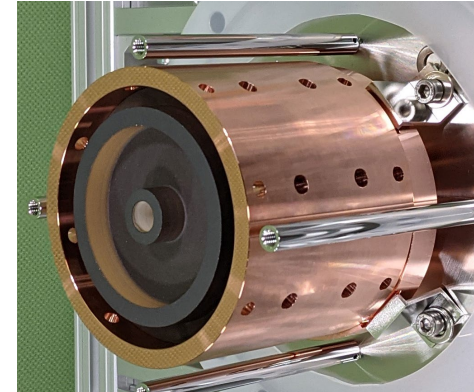
DLC coating is known to reduce secondary electron yield while not increasing dielectric losses.

H. Xu et al., PRAB 22, 021002 (2019).

## 【Secondary electron yield of MgO and DLC surface】



## 【DLC coated dielectric cell & DAA structure】



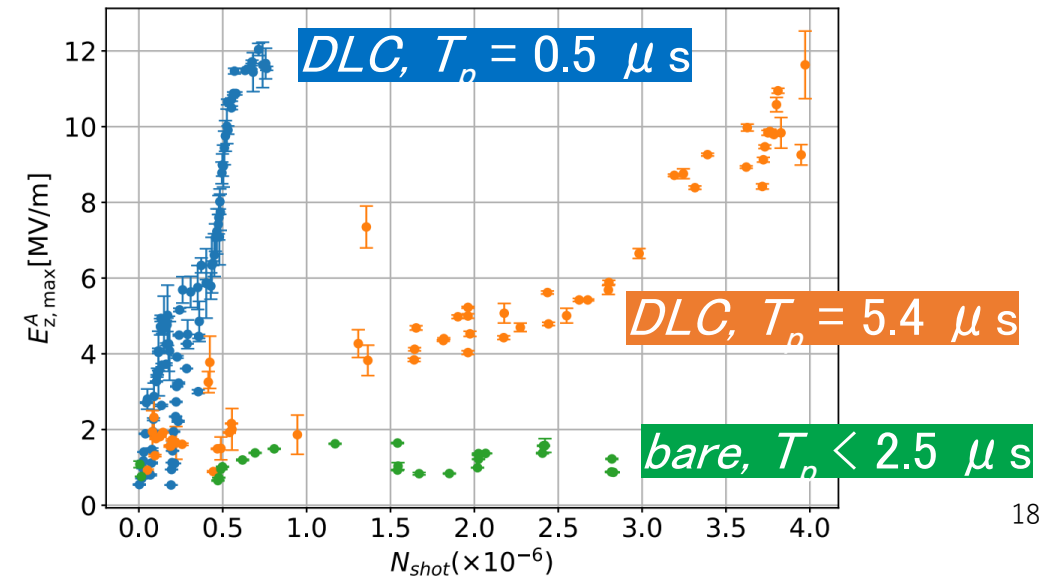
【Low power test<sup>[3]</sup>】

$Q_0$ -uncoated : 112,000

$Q_0$ -DLC(a-C:H) : 113,000

**Maintaining a high  $Q_0$  value !**

## 【High power test of DLC-DAA structures<sup>[3]</sup>】



**Succeeded in significantly reducing SEY of MgO !**

- $E_{acc,max} = 11 \text{ MV/m}$  (@  $T_p = 5.4 \mu s$ ) achieved.<sup>[3]</sup>
- However, a large breakdown caused irreversible deterioration in accelerator performance.

[3] S. Mori, M. Yoshida, D. Satoh, PRAB 24, 022001 (2021)